## Applicant(s)/Patent Under Application/Control No. Reexamination 10/633,150 YANG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Edwin A. León 2833 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 06-2002 Wagner, Douglas L. 439/606 US-6,402,552 Α 04-2003 Simmel, George M. 439/352 US-6,540,542 В 439/736 03-2001 Fusselman et al. US-6,200,171 С 439/352 US-5,580,268 12-1996 Miyazawa, Junichi D 439/357 05-2002 Mayo et al. US-6,383,010 Ε 439/607 08-2002 Kuan, Chi-te F US-6,439,926 US-G US-Н US-1 US-J κ US-US-L US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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